

Application Information

Applicant Type:: Regular
Subject Matter:: Utility
Suggested Classification::
Suggested Group Art Unit::
CD-ROM or CD-R?:: None
Title:: Verfahren zur Messung von
Kennwerten, insbesondere der
Temperature eines
mehrschichtigen Materials
während des Schichtenaufbaus
Attorney Docket Number:: 101215-75
Request for Early Publication?:: No
Request for Non-Publication?:: No
Suggested Drawing Sheets::
Total Drawing Sheets:: 5
Small Entity:: Yes
Petition included?::
Secrecy Order in Parent Appl.?::

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Representative Information

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Domestic Priority Information

Application:: Continuity Type:: Parent Patent
Application:: Filing Date::
None

Foreign Priority Information

Country:: Application Number:: Filing Date::
Germany 100 61 168.0 November 30, 2000

Assignee Information

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